

**Notice of References Cited**

Application/Control No.

10/599514

Applicant(s)/Patent Under  
Reexamination  
PENG ET AL.

Examiner

MICHAEL T. TRAN

Art Unit

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Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0052902	03-2005	Smith et al.	365/158
*	B	US-2004/0246776	12-2004	Covington, Mark William	365/173
*	C	US-2004/0165425	08-2004	Nakamura et al.	365/171
*	D	US-2004/0165320	08-2004	Carey et al.	360/324.11
*	E	US-2004/0082082	04-2004	Li et al.	438/003
*	F	US-2006/0171196	08-2006	Freitag et al.	365/158
*	G	US-2005/0106810	05-2005	Pakala et al.	438/257
*	H	US-2004/0130936	07-2004	Nguyen et al.	365/158
*	I	US-2004/0052127	03-2004	Suzuki et al.	365/200
*	J	US-6,791,868	09-2004	Gider et al.	365/158
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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